High Power RF GaN Amplifier 400 W, 48 V, 3400 - 3800 MHz



MACOM PURE CARBIDE.

MAPC-C38550-CP

Rev. V1

Features

- GaN on SiC HEMT Technology
- Designed for Asymmetrical Doherty Application
- 47.5 dBm Average Output Power
- 400 W Peak Output Power
- Input and Output Pre-matched Device
- Low Thermal Resistance
- 100% DC and RF Tested
- RoHS* Compliant

Applications

- Point-to-Point
- Infrastructure

Description

The MAPC-C38550-CP is a GaN on Silicon Carbide HEMT Amplifier designed for asymmetrical Doherty applications. The device is optimized for the frequency band of 3400 - 3800 MHz. Product is housed in an over-molded TO-package.

Typical Doherty Performance: V_{DS} = 50 V, I_{DQm} = 280 mA, V_{GSpk} = 560 mA - 1.5 V P_{OUT} = 47.5 dBm, T_A = 25°C

Note: Performance in MACOM Doherty Application Fixture. Single Carrier- W-CDMA Channel Bandwidth

3.84 MHz, PAR 10 dB @ 0.01% CCDF.

Frequency (MHz)	Gain (dB)	Efficiency (%)	Output PAR (dB)	ACPR (dBc)
3400	12.3	43	8.3	-32.4
3600	13.9	44.7	8.7	-32.4
3800	12.8	44.5	8.4	-32.5

Ordering Information

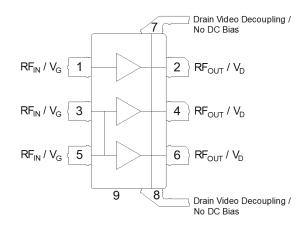
Part Number	Package
MAPC-C38550-CPTR1	250 pcs Tape and Reel ¹
MAPC-C38550-CPSB1	Sample Board

1. See application note AN-0004525 for Tape & Reel information.



TO-248-8L

Functional Schematic



Pin Configuration

Pin#	Pin Name	Function
1	RF _{IN} / V _G	RF Input / Gate (Main)
2	RF _{OUT} / V _D	RF Output / Drain (Main)
3,5	RF _{IN} / V _G	RF Input / Gate (Peak)
4,6	RF _{OUT} / V _D	RF Output / Drain (Peak)
7,8	VBW Lead	Drain Video Decoupling. No DC Bias
9	Flange ²	Ground / Source

2. The flange on the package bottom must be connected to RF, DC and thermal ground.

^{*} Restrictions on Hazardous Substances, compliant to current RoHS EU directive.

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RF Electrical Characterization:

 T_A = 25°C, V_{DS} = 50 V, I_{DQm} = 280 mA, V_{GSpk} = -4.4 V Note: Performance in MACOM Doherty Application Fixture. Single Carrier- W-CDMA Channel Bandwidth 3.84 MHz, PAR 10 dB @ 0.01% CCDF.

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Units
Power Gain	3600 MHz, P _{OUT} = 47.5 dBm	Gp	_	13.9	_	dB
Drain Efficiency	3600 MHz, P _{OUT} = 47.5 dBm	η	_	44.7	_	%
Output CCDF @ 0.01%	3600 MHz, P _{OUT} = 47.5 dBm	PAR	_	8.7	_	dB
Adjacent Channel Power	3600 MHz, P _{OUT} = 47.5 dBm	ACP	_	-32.4	_	dBc
Input Return Loss	3600 MHz, P _{OUT} = 47.5 dBm	IRL	_	-17.2	_	dB
Gain Flatness	3600 MHz, P _{OUT} = 47.5 dBm	G _F	_	1.6	_	dB
Gain Variation (-40°C to +105°C)	3600 MHz, P _{OUT} = 47.5 dBm	ΔG	_	0.02	_	dB/°C
Power Variation (-40°C to +105°C)	3600 MHz, Pulsed 10% DC	ΔP_{3dB}	_	0.002	_	dB/°C
Ruggedness: Output Mismatch	All phase angles	Ψ	VSWR =10:1, No Device Damage			mage

RF Electrical Test Specifications:

 $T_A = 25^{\circ}\text{C}$, $V_{DS} = 50 \text{ V}$, $I_{DQm} = 280 \text{ mA}$, $V_{GSPK} = 560 \text{ mA} - 1.3 \text{ V}$ Note: Performance in MACOM Doherty Production Test Fixture. Single Carrier- W-CDMA Channel Bandwidth 3.84 MHz, PAR 10 dB @ 0.01% CCDF.

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Units
Power Gain	3800 MHz, P _{OUT} = 47.5 dBm	Gp	9.5	11.5		dB
Drain Efficiency	3800 MHz, P _{OUT} = 47.5 dBm	η	27	36		%
Output CCDF @ 0.01%	3800 MHz, P _{OUT} = 47.5 dBm	PAR	5	8.0	_	dB
Adjacent Channel Power	3800 MHz, P _{OUT} = 47.5 dBm	ACP	_	-28.5	-22	dBc



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DC Electrical Characteristics T_A = 25°C

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Units	
Main Amplifier							
Gate-Source Leakage Current	V _{GS} = -8 V, V _{DS} = 50 V	I _{GLK}	-6.5	-	-	mA	
Gate-Source Leakage Current	$V_{GS} = -8 \text{ V}, V_{DS} = 100 \text{ V}$	I _{GLK}	-2.0	-	-	mA	
Gate Threshold Voltage	V _{DS} = 10 V, I _D = 28 mA	V _T	-3.8	-2.8	-2.1	V	
	Peak Amplifier						
Gate-Source Leakage Current	V _{GS} = -8 V, V _{DS} = 50 V	I _{GLK}	-13.0	-	-	mA	
Gate-Source Leakage Current	V _{GS} = -8 V, V _{DS} = 100 V	I _{GLK}	-4	-	-	mA	
Gate Threshold Voltage	V _{DS} = 10 V, I _D = 56 mA	V _T	-3.8	-2.64	-2.1	V	

Recommended Operating Voltages

Parameter	Test Conditions	Units	Min.	Тур.	Max.
Drain Operating Voltage	_	V	_	50	1
Gate Quiescent Voltage	V _{DS} = 48 V, I _D = 280 mA	V	-3.6	-2.85	-2.1

ESD Characteristics

Parameter	Class	Standard
Human Body Model (HBM)	Class 1B	ANSI/ESDA/JEDEC JS-001
Charge Device Model (CDM)	Class 3C	ANSI/ESDA/JEDEC JS-002

Moisture Sensitivity Level

Level	Test Standard	Package Temperature	Unit
3	IPC/JEDEC J-STD-020	260	°C

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Absolute Maximum Ratings 3,4,5,6,7

Parameter	Absolute Maximum
Drain Source Voltage, V _{DS}	100 V
Gate Source Voltage, V _{GS}	-10 to 2 V
Drain Operating Voltage, V _{DS}	55 V
Gate Current (Main), I _G	28 mA
Gate Current (Peak), I _G	56 mA
Storage Temperature Range	-65°C to +150°C
Case Operating Temperature Range	-40°C to +125°C
Channel Operating Temperature Range, T _{CH}	-40°C to +225°C
Absolute Maximum Channel Temperature	+225°C

- 3. Exceeding any one or combination of these limits may cause permanent damage to this device.
- 4. MACOM does not recommend sustained operation above maximum operating conditions.

- Operating at drain source voltage V_{DS} < 55V will ensure MTTF > 2.51 x 10⁶ hours.
 Operating at nominal conditions with T_{CH} ≤ 225°C will ensure MTTF > 2.51 x 10⁶ hours.
 MTTF may be estimated by the expression MTTF (hours) = A e ^[B+C/(T+273)] where *T* is the channel temperature in degrees Celsius., A = 1.93, B = -45.31, and C = 29,585.

Thermal Characteristics⁸

Parameter	Test Conditions	Symbol	Typical	Units
Thermal Resistance using Infrared Measurement of Die Surface Temperature	$P_{DISS} = 123 \text{ W}$ $T_{C}=85^{\circ}\text{C}, T_{SURFACE} = 225^{\circ}\text{C}$	$R_{\theta}(IR)$	0.99	°C/W

^{8.} Case temperature measured using thermocouple embedded in heat-sink. Contact local applications support team for more details on this measurement.

Bias Sequencing Bias ON

- 1. Ensure RF is turned off
- 2. Apply pinch-off voltage of -5 V to the gate
- 3. Apply nominal drain voltage
- 4. Bias gate to desired guiescent drain current
- 5. Apply RF

Bias OFF

- 1. Turn RF off
- 2. Apply pinch-off voltage to the gate
- 3. Turn-off drain voltage
- 4. Turn-off gate voltage

Handling Procedures

Please observe the following precautions to avoid damage:

Static Sensitivity

Gallium Nitride Circuits are sensitive to electrostatic discharge (ESD) and can be damaged by static electricity. Proper ESD control techniques should be used when handling these devices.

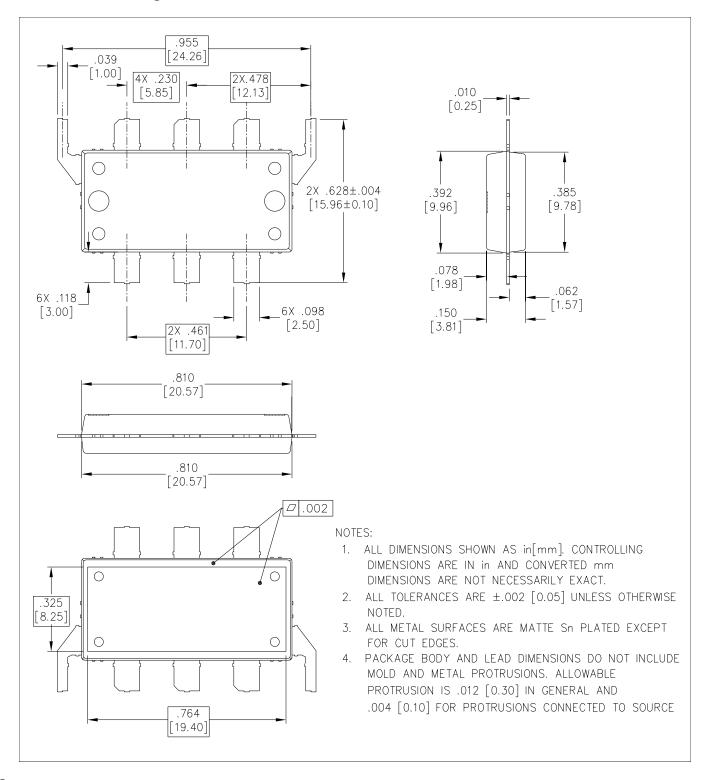


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TO-248-8L Package Dimensions



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